CE

EMC COMPLIANCE TEST REPORT

for

VOIP PHONE AND VOIP PHONE WITH POE

Trade Name	:	DLINK
Model Number	:	DPH-400SE
Serial Number	:	N/A
Report Number	:	PZD1006178-E
Date	:	June 8,2010
Regulations	:	See below

Standards	Results (Pass/Fail)
EN 55022:2006+A1:2007;	PASS
EN 61000-3-2: 2006+A1:2009+A2:2009;	PASS
EN 61000-3-3: 2008;	PASS
EN 55024:1998+A1:2001+A2:2003;	PASS
EN 61000-4-2: 2009;	PASS
EN 61000-4-3: 2006+A1:2008;	PASS
EN 61000-4-4: 2004;	PASS
EN 61000-4-5: 2006;	PASS
EN 61000-4-6: 2007;	PASS
EN 61000-4-11: 2004	PASS

Prepared for:

D-LINK INTERNATIONAL PTE LTD 1 INTERNATIONAL BUSINESS PARK #03-12

Prepared by:

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1 VERIFICATION OF COMPLIANCE

Equipment Under Test:	VOIP PHONE AND VOIP PHONE WITH POE
Trade Name:	DLINK
Model Number:	DPH-400SE
Serial Number:	N/A
EUT Powered during test:	DC5V input from ADAPTER POWERED 230VAC
Applicant:	D-LINK INTERNATIONAL PTE LTD 1 INTERNATIONAL BUSINESS PARK #03-12
Manufacturer:	D-LINK INTERNATIONAL PTE LTD 1 INTERNATIONAL BUSINESS PARK #03-12
Type of Test:	EMC Directive 2004/108/EC for CE Marking
Technical Standards:	EN 55022:2006+A1:2007; EN 61000-3-2: 2006+A1:2009+A2:2009; EN 61000-3-3: 2008; EN 55024:1998+A1:2001+A2:2003; EN 61000-4-2: 2009; EN 61000-4-3: 2006+A1:2008; EN 61000-4-4: 2004; EN 61000-4-5: 2006; EN 61000-4-6: 2007; EN 61000-4-11: 2004
File Number:	PZD1006178-E
Date of test:	June 8, 2010
Deviation:	None
Condition of Test Sample:	Normal

The above equipment was tested by Shenzhen PZD Technology Co.,Ltd. for compliance with the requirements set forth in Directive 2004/108/EC and the Technical Standards mentioned above. This said equipment in the configuration described in this report shows the maximum emission levels emanating from equipment and the level of the immunity endurance of the equipment are within the compliance requirements.

The test results of this report relate only to the tested sample identified in this report.

Approved by Authorized Signatory:

Mark Yan/ Manager

Report Number: PZD1006178-E June 8, 2010

2 SYSTEM DESCRIPTION

EUT Test Program:

- 1. Set up EUT and relative support equipments.
- 2. Connect the net cable to the EUT and /or the PC,working normally
- 3. Keep the program running throughout the test.

3 PRODUCT INFORMATION

Housing Type: EUT Power Rating:	Plastic DC 5V from adapter		
Adapter Manufacturer/Model No:	Input:100-240VAC 50-60Hz 0.2A Max Output:5VDC,1A		
DC Output Cable:	Unshielded, 1.6m		
Net Cable	Unshielded, 1.6m		

I/O Port of EUT:

	I/O Port Type	Q'TY	Tested with	
1)	RJ45 port	2	2	
2)	DC INLET	1	1	

Difference between model numbers as below:

N/A

No.	Equipment	Model #	Serial #	Trade Name	Data Cable	Power Cord
1)	PC	M4600C	NS04619689	LENOVO	N/A	Unshielded 1.8m
2)	Keyboard	SK-8115	CN-0J4635-71616 -61 F-1U27	DELL	Shielded 1.8 m	N/A
3)	Modem	SUPERFAX 6.0	9013593	ACCEX	Shielded 1.5m	Unshielded 1.8m
4)	Mouse	M-S69	323614-001	HP	Shielded 1.8 m	N/A
5)	Monitor	VP201B	A21050402549	View Sonic	Shielded 1.8 m	Shielded 1.5m
6)	RJ45 cable	N/A	N/A	N/A	Unshielded 1.5m	N/A

4 SUPPORT EQUIPMENT

****Note:** All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.

Grounding: Grounding was in accordance with the manufacturer's requirements and conditions for the intended use.

5 TEST FACILITY

Location:	Bldg. 69,Majialong Industrial Zone,Nanshan District,Shenzhen Guangdong,China
Description:	There are one 3 chamber and one line conducted labs for final test. The 3m chamber and the Line Conducted labs are constructed and calibrated to meet the FCC requirements in documents ANSI C63.4 and CISPR 22/EN 55022 requirements.
Site Accreditation:	Accredited by FCC, March 18,2008 The Certificate Registration Number. is 709623 Accredited by Industry Canada, May 24, 2008 The Certificate Registration Number. is 46405-4480 Accredited by CNAS , May 30, 2005 The Certificate Registration Number. is L2291 Accredited by VCCI , April 23, 2005 The Certificate Registration Number. is R-2777
Instrument Tolerance:	All measuring equipment is in accord with ANSI C63.4 and CISPR 22 requirements that meet industry regulatory agency and accreditation agency requirement.

Ground Plane: Two conductive reference ground planes were used during the Line Conducted Emission, one in vertical and the other in horizontal. The dimensions of these ground planes are as below. The vertical ground plane was placed distancing 40 cm to the rear of the wooden test table on where the EUT and the support equipment were placed during test. The horizontal ground plane projected 50 cm beyond the footprint of the EUT system and distanced 80 cm to the wooden test table. For Radiated Emission Test, one horizontal conductive ground plane extended at least 1m beyond the periphery of the EUT and the largest measuring antenna, and covered the entire area between the EUT and the antenna. It has no holes or gaps having longitudinal dimensions larger than one-tenth of a wavelength at the highest frequency of measurement up to 1GHz.

6 TEST EQUIPMENT LIST

Instrumentation: The equipment conforms to the CISPR 16-1 / ANSI C63.2-1988 Specifications for Electromagnetic Interference and Field Strength Instrumentation from 10kHz to 1.0 GHz or above. **Equipment used during the tests:**

	201 001144000					
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1	Test Receiver	Rohde & Schwarz	ESCS30	828985/018	May 12, 2010	1 Year
2	L.I.S.N.	Rohde & Schwarz	ESH2-Z5	834549/005	May 12, 2010	1 Year
3	RF Cable	FUJIAKURA	3D-2W	No.1	May 12, 2010	1 Year
4	Pulse Limiter	Rohde & Schwarz	ESH3-Z2	100006	May 12, 2010	1 Year
5	Coaxial Switch	Anritsu	MP59B	M20531	May 12, 2010	1 Year

For Conducted Emission Test

For Radiation Emission Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1	Spectrum Analyzer	ADVANTENT	R3132	N/A	May 12, 2010	1 Year
2	LISN(EUT)	EMCO	3825/2	1371	May 12, 2010	1 Year
3	LISN	EMCO	3825/2	8901-1459	May 12, 2010	1 Year
4	Spectrum Analyzer	ADVANTENT	R3132	N/A	May 12, 2010	1 Year

For Harmonic & Flicker Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Power					
	Frequency	HAEFELY	PHF555	080419-03	May 12, 2010	1Year
	System					
2.	PC	N/A	P2L97	N/A	N/A	N/A

For Electrostatic Discharge Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	ESD Tester	HAEFELY	PESD1600	H708159	May 12, 2010	1 Year

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval	
1.	Signal Generator	Maconi	2022D	119246/003	May 12, 2010	1Year	
2.	Power Amplifier	M2S	A00181/1000	9801-112	May 12, 2010	1Year	
3.	Power Amplifier	M2S	AC8113/ 800-250A	9801-179	May 12, 2010	1 Year	
4.	Power Antenna	SCHAFFNER	CBL6140A	1204	May 12, 2010	1 Year	

For RF Strength Susceptibility Test

For Electrical Fast Transient /Burst Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Burst Tester	HAEFELY	PEFT4010	080981-16	May 12, 2010	1 Year
2	Coupling Clamp	HAEFELY	IP-4A	147147	May 12, 2010	1Year

For Surge Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Surge Tester	HAEFELY	PSURGE4.1	080107-04	May 12, 2010	1Year

For Injected Current Susceptibility Test

	U	ž				
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Simulator	EMTEST	CWS500C	0900-12	May 12, 2010	1Year
2.	CDN	EMTEST	CDN-M2	5100100100	May 12, 2010	1Year
3.	CDN	EMTEST	CDN-M3	0900-11	May 12, 2010	1Year
4	Injection Clamp	EMTEST	F-2031-23MM	368	May 12, 2010	1Year
5	Attenuator	EMTEST	ATT6	0010222A	May 12, 2010	1 Year

For Magnetic Field Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1	Magnetic Field	HAEFELY	MAG100	250040.1	May 12, 2010	1 Year
	Tester					
2	2 AC Transformer CHOKUN		TDGC2J-5	N/A	N/A	N/A

For Voltage Dips and Interruptions Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Dips Tester	HAEFELY	Pline1610	083732-18	May 12, 2010	1Year

The calibrations of the measuring instruments, including any accessories that may effect such calibration, are checked frequently to assure their accuracy. Adjustments are made and correction factors applied in accordance with instructions contained in the manual for the measuring instrument.

SECTION 1 LINE CONDUCTED, COMMON MODE CONDUCTED

EMISSION FOR TELECOMMUNICATION PORTS AND RADIATED

EMISSION

MEASUREMENT PROCEDURE (PRELIMINARY LINE CONDUCTED EMISSION TEST)

- The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN55022 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- 2) Support equipment, if needed, was placed as per EN55022.
- 3) All I/O cables were positioned to simulate typical actual usage as per EN55022.
- 4) The EUT received DC power from a adapter received power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.
- 5) All support equipments received power from a second LISN supplying power of AC 230V/50Hz, if any.
- 6) The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT. The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.
- 7) Analyzer / Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.
- 8) During the above scans, the emissions were maximized by cable manipulation.
- 9) The following test mode(s) were scanned during the preliminary test:

Prelimina	ary Conduc	ted Emission Test	L	
Frequency Range Inves	stigated	150KHz TO 30 MHz		
Mode of operation	Date	Data Report No.	Worst Mode	
Normal	2010-06-05	DPH-400SE_0(L, N)	\square	

Then, the EUT configuration and cable configuration of the above highest emission level were recorded for reference of final testing.

MEASUREMENT PROCEDURE (FINAL LINE CONDUCTED EMISSION TEST)

- 1) EUT and support equipment was set up on the test bench as per step 9 of the preliminary test.
- 2) A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less –2dB to the A.V. limit in Peak mode, then the emission signal was re-checked using an Average detector.
- 3) The test data of the worst case condition(s) was reported on the Summary Data page.

]	Freq.	Peak	Q.P.	Average Raw	Q.P.	Average	Q.P.	Average	Note
1	MHz	Raw	Raw	dBuV	Limit	Limit	Margin	Margin	
		dBuV	dBuV		dBuV	dBuV	dB	dB	
х	X.XXX	43.90			56.00	46.00		-2.10	L1

Freq.
Raw dBuV
Limit dBuV
Margin dB
Note
···

- = Emission frequency in MHz
- = Uncorrected Analyzer/Receiver reading
- = Limit stated in standard
- = Reading in reference to limit
- = Current carrying line of reading
- = The emission level complied with the Average limits, with at least 2 dB margin, so no further recheck.

LINE CONDUCTED EMISSION LIMIT

Frequency	Maximum RF Line Voltage			
	Q.P.	AVERAGE		
150kHz-500kHz	66-56dBuV	56-46dBuV		
500kHz-5MHz	56dBuV	46dBuV		
5MHz-30MHz	60dBuV	50dBuV		

****Note:** The lower limit shall apply at the transition frequency.

EN 55022 MEASUREMENT PROCEDURE

(TEST PROCEDURE OF COMMON MODE CONDUCTED EMISSION FOR

TELECOMMUNICATION PORTS)

- 1) Selecting ISN for unscreened cable or a current probe for screened cable to take measurement.
- 2) The port of the EUT was connected to the remote side support equipment through the ISN/Current Probe and communication in normal condition.
- 3) Making a overall range scan by using the test receiver controlled by controller and record at least six highest emissions for showing in the test report.
- 4) Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit.
- 5) In case of measuring on the screened cable, the current limit shall be applied, otherwise the voltage limit should be applied.

COMMON MODE Conducted Emission Test(TELECOMMUNICATION PORTS)						
Frequency Range Investi	gated	150KHz TO 30 MHz				
Mode of operation	Mode of operation Date		Worst Mode			
Normal	2010-06-05	DPH-400SE_0	\boxtimes			

6) The following test mode was scanned during the preliminary test:

Then, the EUT configuration and cable configuration of the above highest emission level were recorded for reference of final testing.

Data Sample:

FREQ MHz	PEAK Raw dBuA	QP Raw dBuA	AVG Raw dBuA	QP Limit dBuA	AVG Limit dBuA	QP Margin dB	AVG Margin dB
XX.XXX	61.02			74.00	64.00		-3.08

Freq.

= Emission frequency in MHz

Raw dBuV = Analyzer/Receiver reading + Insertion Loss

Limit dBuV = Limit stated in standard

Margin dB = Reading in reference to limit

Note

= Current carrying line of reading

"---" = The emission level complied with the Average limits, at least 2dB margin limits, so no recheck anymore.

COMMON MODE CONDUCTED EMISSION LIMIT

(TELECOMMUNICATION PORTS)

Frequency	Current Lir	nits (dBuA)
	Quasi-Peak	AVERAGE
150kHz-500kHz	84-74	74-64
500kHz-30MHz	74	64

****Note:** The lower limit shall apply at the transition frequency.

MEASUREMENT PROCEDURE

(PRELIMINARY RADIATED EMISSION TEST)

- The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane as per EN 55022 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- 2) Support equipment, if needed, was placed as per EN 55022.
- 3) All I/O cables were positioned to simulate typical actual usage as per EN 55022.
- 4) The EUT received from a adapter. Run cpoytest program and other suitable program. All support equipments received AC 230V/50Hz power from socket under the turntable, if any.
- 5) The antenna was placed at 3 meter away from the EUT as stated in EN 55022. The antenna connected to the Analyzer via a cable and at times a pre-amplifier would be used.
- 6) The Analyzer / Receiver quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- 7) The following test mode(s) were scanned during the preliminary test:

Preliminary Radiated Emission Test								
Frequency Range Inv	restigated	30 MHz TO 1000	MHz					
Mode of operation	Date	Data Report No.	Worst Mode					
Normal	2010-06-05	DPH-400SE_0(H, V)	\boxtimes					

Then, the EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for final testing.

MEASUREMENT PROCEDURE (FINAL RADIATED EMISSION TEST)

- 1) EUT and support equipment were set up on the turntable as per step 7 of the preliminary test.
- 2) The Analyzer / Receiver scanned from 30MHz to 1000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- 3) Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and Q.P./Peak reading is presented.
- 4) The test data of the worst case condition(s) was reported on the Summary Data page.

Data Sample:

Freq.	Raw Data	Corr. Factor	Emiss. Level	Limits	Margin	Reading Type		
(MHz)	(dBuV/m)	(dB) (dB	BuV/m)	(dB)	P/Q			
xxx.xxx	24.03	22.25	36.28	40.00	-3.72	Р		
F	Freq.			= Emis	sion frequency in	MHz		
F	Raw Data (dE	BuV/m)		= Uncorrected Analyzer / Receiver reading				
(Corr. Factor (dB)		= Correction factors of antenna factor and cable loss				
E	Emiss. Level			= Raw reading converted to dBuV/m and CF added				
I	Limit dBuV/n	n		= Limit stated in standard				
Margin dB				= Reading in reference to limit				
Р				ak Reading				
Q				=Quasi-peak				

RADIATED EMISSION LIMIT

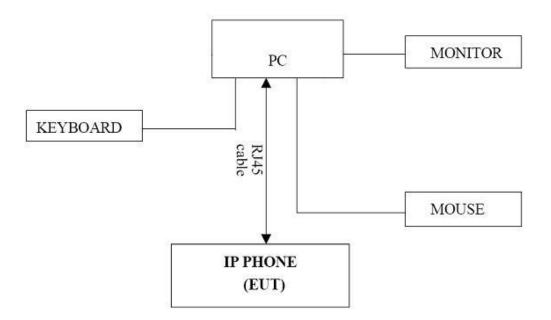
Frequency	Distance	Maximum Field Strength Limit
(MHz)	(m)	(dBuV/m/ Q.P.)
30-230	3	40
230-1000	3	47

****Note:** The lower limit shall apply at the transition frequency.

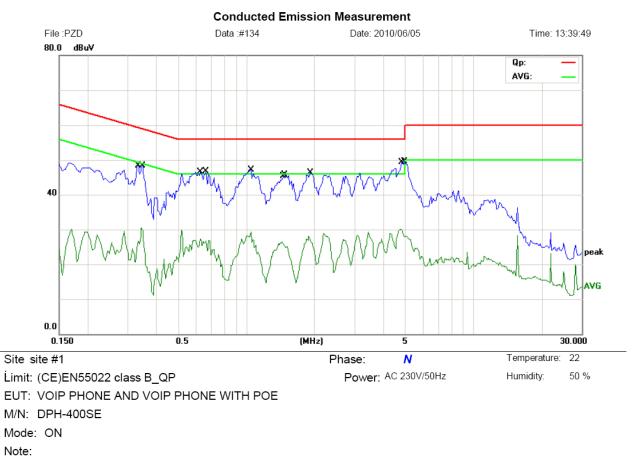
BLOCK DIAGRAM OF TEST SETUP

EUT : VOIP PHONE AND VOIP PHONE WITH POE

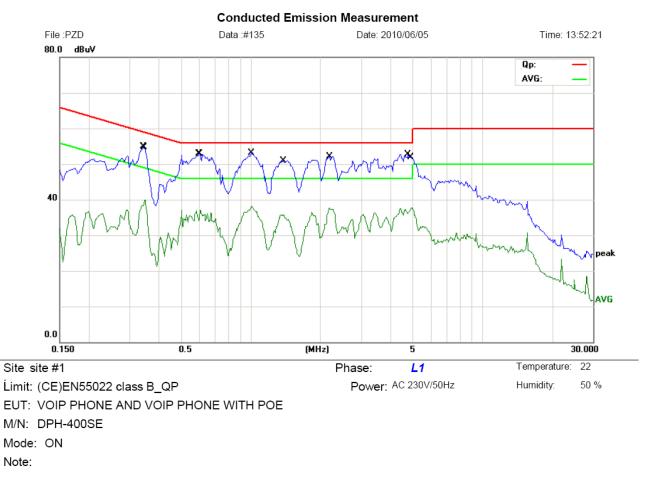
Trade Name : N/A Model Number : DPH-400SE



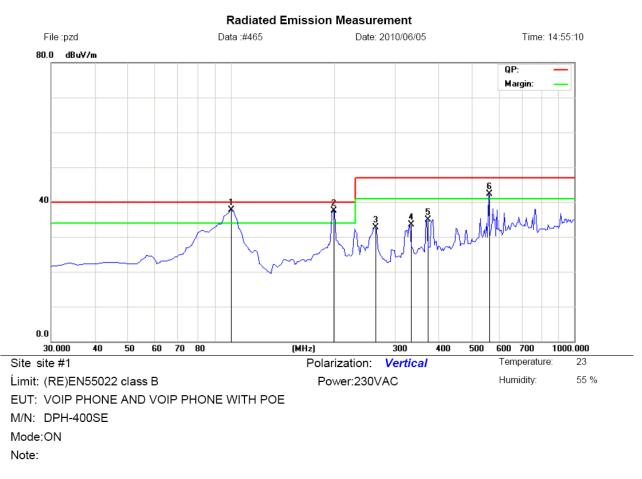
¥



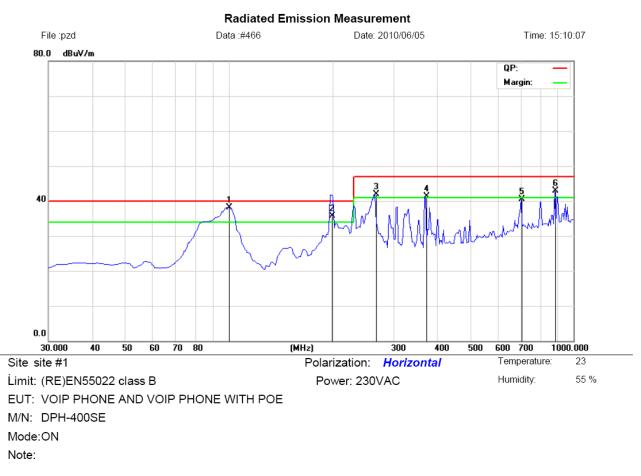
No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1		0.3350	48.39	0.00	48.39	59.33	-10.94	QP	
2		0.3450	30.56	0.00	30.56	49.08	-18.52	AVG	
3		0.6305	27.14	0.00	27.14	46.00	-18.86	AVG	
4		0.6650	46.61	0.00	46.61	56.00	-9.39	QP	
5		1.0500	47.03	0.00	47.03	56.00	-8.97	QP	
6		1.0500	29.28	0.00	29.28	46.00	-16.72	AVG	
7		1.4400	26.42	0.00	26.42	46.00	-19.58	AVG	
8		1.4750	45.71	0.00	45.71	56.00	-10.29	QP	
9		1.8850	28.10	0.00	28.10	46.00	-17.90	AVG	
10		1.9100	46.24	0.00	46.24	56.00	-9.76	QP	
11		4.8200	30.09	0.00	30.09	46.00	-15.91	AVG	
12	*	4.9700	49.53	0.00	49.53	56.00	-6.47	QP	



No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
	MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1	0.3450	54.92	0.00	54.92	59.08	-4.16	QP	
2	0.3500	39.99	0.00	39.99	48.96	-8.97	AVG	
3	0.6000	52.85	0.00	52.85	56.00	-3.15	QP	
4	0.6050	37.14	0.00	37.14	46.00	-8.86	AVG	
5 *	1.0100	53.11	0.00	53.11	56.00	-2.89	QP	
6	1.0100	38.18	0.00	38.18	46.00	-7.82	AVG	
7	1.3850	50.91	0.00	50.91	56.00	-5.09	QP	
8	1.3850	35.79	0.00	35.79	46.00	-10.21	AVG	
9	2.1900	52.13	0.00	52.13	56.00	-3.87	QP	
10	2.1900	37.65	0.00	37.65	46.00	-8.35	AVG	
11	4.7800	52.75	0.00	52.75	56.00	-3.25	QP	
12	4.9400	37.68	0.00	37.68	46.00	-8.32	AVG	



No.	Mł	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1	*	100.2286	23.90	13.71	37.61	40.00	-2.39	peak			
2	İ	199.2855	23.90	13.52	37.42	40.00	-2.58	peak			
3		262.8000	19.90	12.89	32.79	47.00	-14.21	peak			
4		332.6400	18.62	14.85	33.47	47.00	-13.53	peak			
5		373.3800	18.60	16.21	34.81	47.00	-12.19	peak			
6	İ	563.5000	22.60	19.66	42.26	47.00	-4.74	peak			



No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1	*	100.2286	24.45	13.70	38.15	40.00	-1.85	QP			
2	İ	199.0000	24.37	11.41	35.78	40.00	-4.22	QP			
3	İ	266.6800	27.89	14.10	41.99	47.00	-5.01	QP			
4	ļ	373.3800	24.52	16.76	41.28	47.00	-5.72	QP			
5		707.0600	17.68	22.83	40.51	47.00	-6.49	QP			
6	ļ	883.6000	18.72	24.11	42.83	47.00	-4.17	QP			

SECTION 2 EN 61000-3-2 & EN 61000-3-3 (POWER HARMONICS &

VOLTAGE FLUCTUATION / FLICKER)

POWER HARMONICS MEASUREMENT

Port: AC mainsBasic Standard: EN 61000-3-2

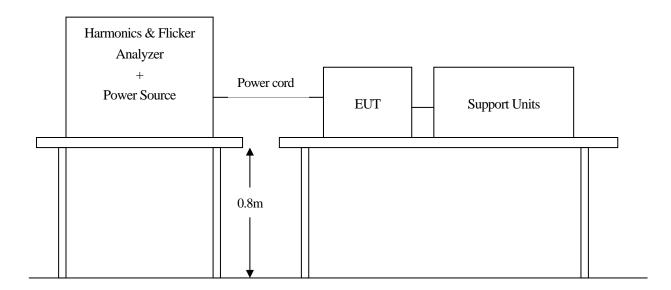
Limits	: V CLASS A; CLASS D
Temperature	: 25°C
Humidity	: 55%

VOLTAGE FLUCTUATION/FLICKER MEASUREMENT

Port	: AC mains
Basic Standard	: EN 61000-3-3

Limits	: § 5 of EN 61000-3-3
Temperature	: 25°C
Humidity	: 55%

Block Diagram of Test Setup:



Result:

Please see the attached test data. According to the standard ,EN61000-3-2 need not to be carried out.

Model No.:DPH-400SE

Voltage Variations :		
Highest Level:	+2.24%	
Lowest Level:	+0.56%	
d(max):	1.67%	PASS
Highest d(t) of 500ms:	0.00%	PASS
Present d(t) over 3.33%:	0.00 Seconds	
Longest d(t) over 3.33%:	0.02 Seconds	
Highest Steady State:	+1.09%	
Lowest Steady State:	+0.80%	
Max d(c) Between Adjacent:	0.29%	PASS
Max d(c) Between Any:	0.29%	
Short Term Flicker Pst:	0.18	PASS

Flicker Results :			
Pst Classifier		Plt Calculatio	on
Duration	Flicker	Interval	Pst
0.1%	1.03		
0.7%	0.02		
1.0%	0.02		
1.5%	0.02		
2.2%	0.00		
3%	0.00		
4%	0.00		
6%	0.00		
8%	0.00		
10%	0.00		
13%	0.00		
17%	0.00		
30%	0.00		
50%	0.00		
80%	0.00		

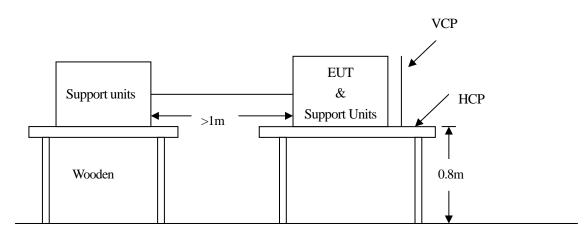
SECTION 3 EN 61000-4-2 (ELECTROSTATIC DISCHARGE)

ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

Port	:	Enclosure
Basic Standard	:	EN 61000-4-2
Test Level	:	\pm 8 kV (Air Discharge)
		$\pm 4 kV$ (Contact Discharge)
Performance Criteria	:	B (Standard require)
Temperature	:	23°C
Humidity	:	55%

Block Diagram of Test Setup:

(The 470 k ohm resistors are installed per standard requirement)



Ground Reference Plane

Test Procedure:

- 1. The EUT was located 0.1 m minimum from all side of the HCP.
- 2. The support units were located 1 m minimum away from the EUT.
- 3. Set up EUT and relative support equipments. Then ping the IP from PC to EUT in windows XP.Keep the program running throughout the test.
- 4. Active the communication function if the EUT with such port(s).
- 5. As per the requirement of EN 55024; applying direct contact discharge at the sides other than front of EUT at minimum 50 discharges (25 positive and 25 negative) if applicable, can't be applied direct contact discharge side of EUT then the indirect discharge shall be applied. One of the test points shall be subjected to at least 50 indirect discharge (contact) to the front edge of horizontal coupling plane.
- 6. Other parts of EUT where it is not possible to perform contact discharge then selecting appropriate points of EUT for air discharge, a minimum of 10 single air discharges shall be applied.
- 7. The application of ESD to the contact of open connectors is not required.
- 8. Putting a mark on EUT to show tested points. The following test condition was followed during the tests.

Note: As per the A2 to EN 61000-4-2, a bleed resistor cable is connected between the EUT and HCP during the test.

Amount of Discharges	Voltage	Coupling	Result (Pass/Fail)
Mini 25 /Point	$\pm 2kV$; $\pm 4kV$; $\pm 8kV$	Contact Discharge	Pass
Mini 25 /Point	$\pm 2kV; \pm 4kV; \pm 8kV$	Indirect Discharge HCP (Front)	Pass
Mini 25 /Point	$\pm 2kV; \pm 4kV; \pm 8kV$	Indirect Discharge VCP (Left)	Pass
Mini 25 /Point	$\pm 2kV; \pm 4kV; \pm 8kV$	Indirect Discharge VCP (Back)	Pass
Mini 25 /Point	$\pm 2kV; \pm 4kV; \pm 8kV$	Indirect Discharge VCP (Right)	Pass
Mini 10/Point	$\pm 2kV; \pm 4kV; \pm 8kV$	Air Discharge	Pass

The electrostatic discharges were applied as follows:

Performance & Result:

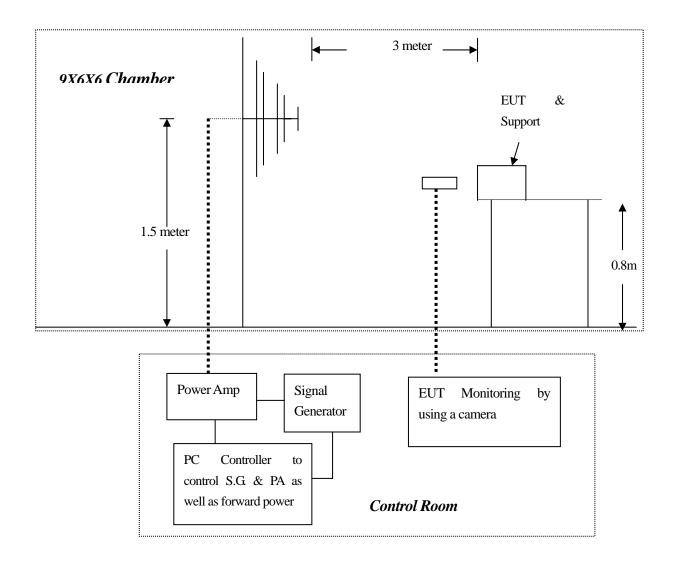
V Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

SECTION 4 EN 61000-4-3 (RADIATED ELECTROMAGNETIC FIELD)

RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

Port	:	Enclosure
Basic Standard	:	EN 61000-4-3:
Requirements	:	3 V/m with 80% AM. 1kHz Modulation.
Performance Criteria	:	A (Standard require)
Temperature	:	23°C
Humidity	:	56%

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT was located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity. The support units were located outside of the uniformity area, but the cable(s) connected with EUT were exposed to the calibrated field as per EN 61000-4-3.
- 2. EUT was loaded and executed in windows WINDOWS XP.
- 3. Setting the testing parameters of RS test software per EN 61000-4-3.
- 4. Performing the pre-test at each side of with double specified level (6V/m) at 4% steps.
- 5. From the result of pre-test in step 4, choose the worst side of EUT for final test from 80 MHz to 1000 MHz at 1% steps.
- 6. Recording the test result in following table.
- 7. It is not necessary to perform test as per annex A of EN 55024 if the EUT doesn't belong to TTE product.

EN 61000-4-3 test conditions:

Test level	: 6V/m
Steps	1 % of fundamental

Dwell Time : 1 sec

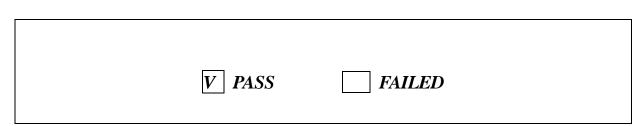
Range (MHz)	Field	Modulation	Polarity	Position (°)	Result (Pass/Fail)
80-1000	3V/m	Yes	Н	Front	Pass
80-1000	3V/m	Yes	V	Front	Pass
80-1000	3V/m	Yes	Н	Right	Pass
80-1000	3V/m	Yes	V	Right	Pass
80-1000	3V/m	Yes	Н	Back	Pass
80-1000	3V/m	Yes	V	Back	Pass
80-1000	3V/m	Yes	Н	Left	Pass
80-1000	3V/m	Yes	V	Left	Pass

Performance & Result:

V Criteria A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

Criteria B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

Criteria C: Temporary loss of function is allowed, provided the functions self-recoverable or can be restored by the operation of controls.

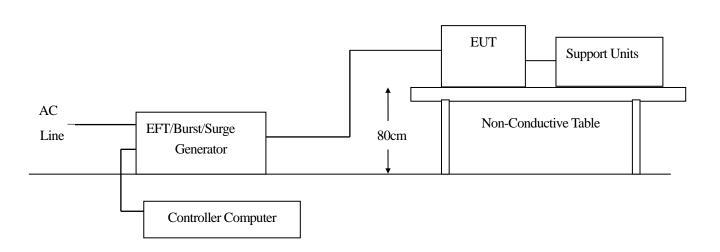


SECTION 5 EN 61000-4-4 (FAST TRANSIENTS/BURST)

FAST TRANSIENTS/BURST IMMUNITY TEST

Port	: On Power Supply Lines
Basic Standard	: EN 61000-4-4:
Requirements	: +/- 1kV for Power Supply Lines
Performance Criteria	: B (Standard require)
Temperature	: 23°C
Humidity	: 55%

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located on a wooden table 0.8 m away from ground reference plane.
- 2. A 1.0 meter long power cord was attached to EUT during the test.
- 3. The length of communication cable between communication port and clamp was keeping within 1 meter.
- 4. Set up all the devices regularly according to the standard.
- 5. Set up EUT and relative support equipments. Then ping the IP from PC to EUT in windows XP.Keep the program running throughout the test.
- 6. Related peripherals work during the test.
- 7. Recording the test result as shown in following table.

Test conditions:

Impulse Frequency: 5kHz Tr/Th: 5/50ns Burst Duration: 15ms Burst Period: 300ms

Inject Line	Voltage kV	Inject Method	Result (Pass/Fail)
L	+/- 1	Direct	Pass
Ν	+/- 1	Direct	Pass
PE	+/- 1	Direct	Pass
L+N	+/- 1	Direct	Pass
L+PE	+/- 1	Direct	Pass
N+PE	+/- 1	Direct	Pass
L+N+PE	+/- 1	Direct	Pass

Performance & Result:

Criteria A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

Criteria B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

Criteria C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.



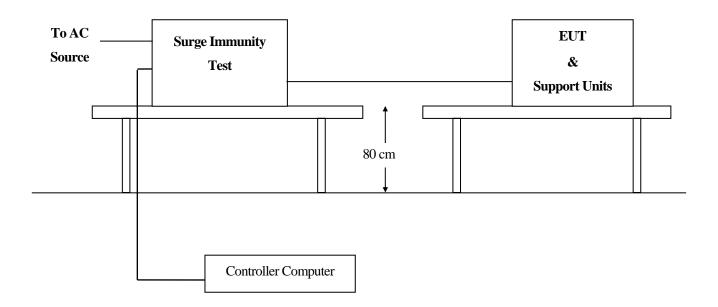
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SECTION 6 EN 61000-4-5 (SURGE IMMUNITY)

SURGE IMMUNITY TEST

Port Basic Standard	: On Power Supply Lines : EN 61000-4-5
Requirements	: +/- 1kV (Line to Line)
	: +/- 2kV (Line to Ground)
Performance Crite	ria: B (Standard require)
Temperature	: 23°C
Humidity	: 56%

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located on a wooden table 0.8 m away from ground floor.
- 2. Set up all the devices regularly according to the standard.
- 3. Set up EUT and relative support equipments. Then ping the IP from PC to EUT in windows XP.Keep the program running throughout the test
- 4. Related peripherals work during the test.
- 5. Recording the test result as shown in following table.

Test conditions:

Voltage Waveform	: 1.2/50 <i>u</i> s
Current Waveform	: 8/20 us
Polarity	: Positive/Negative
Phase angle	$:0^{\circ}, 90^{\circ}, 270^{\circ}$
Number of Test	:5

Coupling Line	Voltage (kV)	Polarity	Coupling Method	Result (Pass/Fail)
L1-L2	1	Positive	Capacitive	Pass
L1-PE	2	Positive	Capacitive	Pass
L2-PE	2	Positive	Capacitive	Pass
L1-L2	1	Negative	Capacitive	Pass
L1-PE	2	Negative	Capacitive	Pass
L2-PE	2	Negative	Capacitive	Pass

Performance & Result:

V	Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is
		allowed below a performance level specified by the manufacturer, when the apparatus is used as
		intended. In some cases the performance level may be replaced by a permissible loss of performance.

Criteria B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

Criteria C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

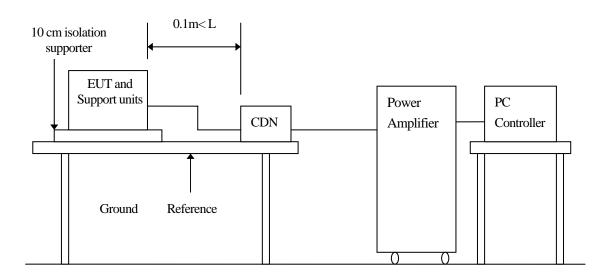


SECTION 7 EN 61000-4-6(CONDUCTED DISTRBANCE/INDUCED BY

RADIO-FREQUENCY FIELD)

Port	: On Power Supply Lines
Basic Standard	: EN 61000-4-6
Requirements	: 3V with 80% AM. 1kHz Modulation
Injection Method	: CDN
Performance Criteria	: A (Standard require)
Temperature	: 23°C
Humidity	: 55%

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.
- 2. Set up all the devices regularly according to the standard.
- 3. Set up EUT and relative support equipments. Then ping the IP from PC to EUT in windows XP.Keep the program running throughout the test
- 4. Related peripherals work during the test.
- 5. Setting the testing parameters of CS test software per EN 61000-4-6.
- 6. Recording the test result in following table.

Test conditions:

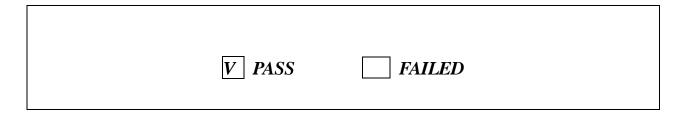
Frequency Range	: 0.15MHz-80MHz
Frequency Step	: 1% of fundamental
Dwell Time	: 1 sec

Range (MHz)	Field	Modulation	Result (Pass/Fail)
0.15-80	3V	Yes	Pass

Performance & Result:

V Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is
	allowed below a performance level specified by the manufacturer, when the apparatus is used as
	intended. In some cases the performance level may be replaced by a permissible loss of performance.

- Criteria B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- Criteria C: Temporary loss of function is allowed, provided the functions self-recoverable or can be restored by the operation of controls.



SECTION 8 EN 61000-4-11 (VOLTAGE DIPS, SHORT INTERRUPTIONS AND VOLTAGE VARIATIONS)

VOLTAGE DIPS / SHORT INTERRUPTIONS

Port	: On Power Supply Lines
Basic Standard	: EN 61000-4-11

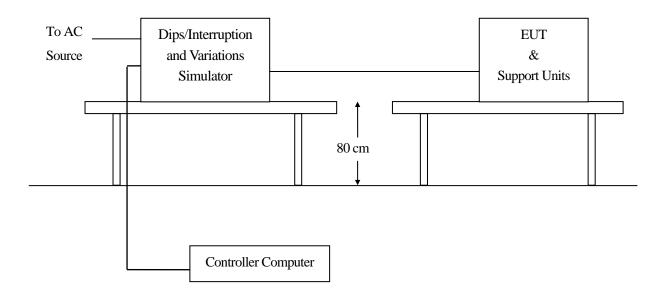
Requirement : PHASE ANGLE 0, 45, 90, 135, 180, 225, 270, 315 degrees

	Test Level	Reduction	Duration	Performance
Voltage	% U _T	(%)	(periods)	Criteria
Dips	<5	>95	0.5	В
	70	30	25	С

Voltage	Test Level	Reduction	Duration	Performance
	% U _T	(%)	(periods)	Criteria
Interceptions	<5	>95	250	С

Test Interval: Min. 10 sec.Temperature: 23°CHumidity: 55%

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located on a wooden table, 0.8 m away from ground floor.
- 2. Set up all the devices regularly according to the standard.
- 3. Set up EUT and relative support equipments. Then ping the IP from PC to EUT in windows XP.Keep the program running throughout the test
- 4. Setting the parameter of tests and then Perform the test software of test simulator.
- 5. Conditions changes to occur at 0 degree crossover point of the voltage waveform.
- 6. Recording the test result in test record form.

Test conditions:

The duration with a sequence of three dips/interruptions with interval of 10 s minimum (Between each test event)

Voltage Dips:

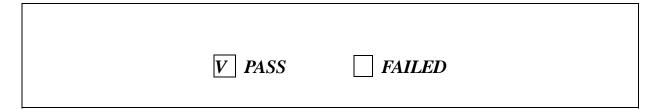
Test Level	Reduction	Duration	Observation	Meet Performance
% U _T	(%)	(periods)		Criteria
0	100	0.5	Normal	А
70	30	25	Normal	А

Voltage Interruptions:

Test Level	Reduction	Duration	Observation	Meet Performance
% U _T	(%)	(periods)		Criteria
0	100	250	EUT shut down, but can recover by operator.	С

Performance & Result:

- **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.



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APPENDIX 1

PHOTOGRAPHS OF TEST SETUP

Rev. 00

CONDUCTED EMISSION TEST (EN 55022)



RADIATED EMISSION TEST (EN 55022)





POWER HARMONIC & VOLTAGE FLUCTUATION / FLICKER TEST (EN 61000-3-2, EN 61000-3-3)

ELECTROSTATIC DISCHARGE TEST (EN 61000-4-2)





RADIATED ELECTROMAGNETIC FIELD (EN 61000-4-3)

FAST TRANSIENTS/BURST TEST (EN 61000-4-4)

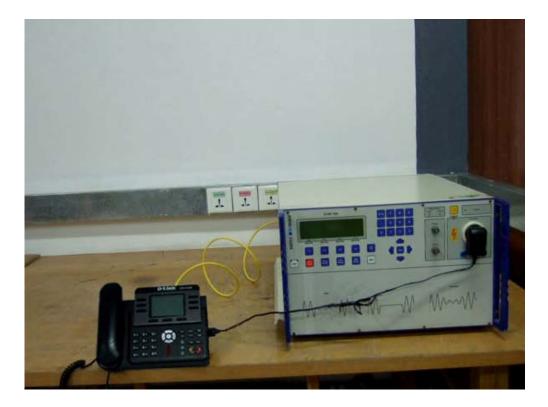


SURGE IMMUNITY TEST (EN 61000-4-5)



CS (EN 61000-4-6)





VOLTAGE DIPS / INTERRUPTION TEST (EN 61000-4-11)

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APPENDIX 2

PHOTOGRAPHS OF EUT

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Rev. 00

EUT FRONT VIEW



EUT – Rear View



EUT – Port View



EARPHONE OUTLET



EUT -- Covered View



EUT –PCB View

